

UNISONIC TECHNOLOGIES CO., LTD

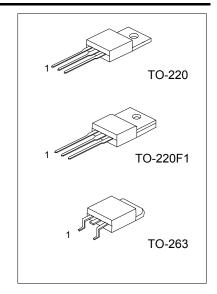
12N50 **Preliminary Power MOSFET**

12A, 500V N-CHANNEL **POWER MOSFET**

DESCRIPTION

The UTC 12N50 is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

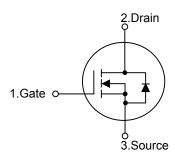
The UTC 12N50 is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.



FEATURES

- * $R_{DS(ON)}$ =0.54 Ω @ V_{GS} =10V
- * High Switching Speed
- * 100% Avalanche Tested

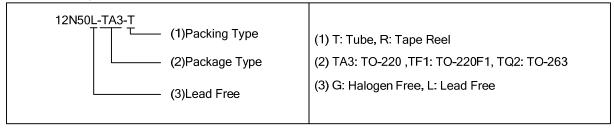
SYMBOL



ORDERING INFORMATION

Ordering Number		Dooksons	Pin Assignment			Daaldaa	
Lead Free	Halogen Free	Package	1	2	3	Packing	
12N50L-TA3-T	12N50G-TA3-T	TO-220	G	D	S	Tube	
12N50L-TF1-T	12N50G-TF1-T	TO-220F1	G	D	S	Tube	
12N50L-TQ2-T	12N50G-TQ2-T	TO-263	G	D	S	Tube	
12N50L-TQ2-R	12N50G-TQ2-R	TO-263	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



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■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	500	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Drain Current	Continuous (T _C =25°C)	I_{D}	12 (Note 2)	А	
	Pulsed (Note 3)	I _{DM}	48 (Note 2)	Α	
Avalanche Current (Note 3)		I _{AR}	12	Α	
Avalanche Energy	Single Pulsed (Note 4)	E _{AS}	684	mJ	
	Repetitive (Note 5)	E _{AR}	19.5	mJ	
Peak Diode Recovery dv/dt (Note 5)		dv/dt	4.5	V/ns	
Power Dissipation	TO-220/ TO-263		192	10/	
(T _C =25°C)	TO-220F1		42	W	
Derate above 25°C	TO-220/ TO-263	P _D	1.53	M//9C	
	TO-220F1		0.33	W/°C	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T _{STG}	-55~+150	°C	

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Drain current limited by maximum junction temperature
- 3. Repetitive Rating: Pulse width limited by maximum junction temperature
- 4. L =9.5mH, I_{AS} = 12A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 5. $I_{SD} \le 12A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
lunation to Oasa	TO-220/ TO-263	0	0.65	°0/14/
Junction to Case	TO-220F1	θ _{JC}	3.0	°C/W

■ **ELECTRICAL CHARACTERISTICS** (T_C=25°C, unless otherwise specified)

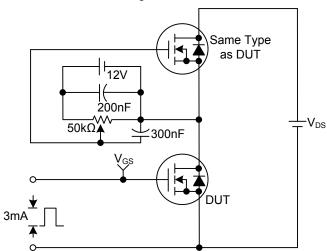
PARAMETER		SYMBOL	TEST CONDITIONS MIN		TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV_{DSS}	I _D =250μA, V _{GS} =0V				V	
Drain-Source Leakage Current		I _{DSS}	V_{DS} =500V, V_{GS} =0V			10	μΑ	
Gate- Source Leakage Current	Forward	」 ,	V_{GS} =+30V, V_{DS} =0V			+100	nΑ	
	Reverse	I_{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_{D}=250\mu A$ 2.0			4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =6A		0.42	0.54	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		C _{ISS}			1450	1930	pF	
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		198	265	pF	
Reverse Transfer Capacitance		C_{RSS}			14.5	22	pF	
SWITCHING PARAMETERS								
Total Gate Charge		Q_G	101/1/ 400// 400		30	39	nC	
Gate to Source Charge		Q_GS	V _{SS} =10V, V _{DS} =400V, I _D =12A (Note 1, 2)		8		nC	
Gate to Drain Charge		Q_GD			12		nC	
Turn-ON Delay Time		$t_{D(ON)}$	V _{DD} =250V, I _D =12A, R _G =25Ω (Note 1, 2)		28	65	ns	
Rise Time		t_R			54	120	ns	
Turn-OFF Delay Time		t _{D(OFF)}			75	160	ns	
Fall-Time		t_{F}			47	105	ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is				12	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				48	Α	
Drain-Source Diode Forward Voltage		V_{SD}	I _S =12A, V _{GS} =0V			1.5	V	
Body Diode Reverse Recovery Time		t _{rr}	I _S =12A, V _{GS} =0V, dI _F /dt=100A/μs		154		ns	
Body Diode Reverse Recovery Charge		Q_{RR}	(Note 1)		0.45		μC	

Note: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

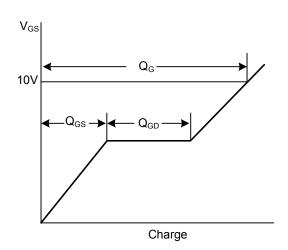
^{2.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

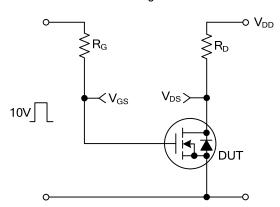
Gate Charge Test Circuit



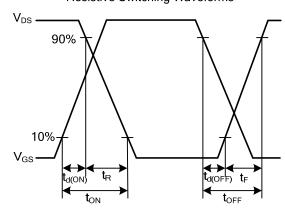
Gate Charge Waveforms



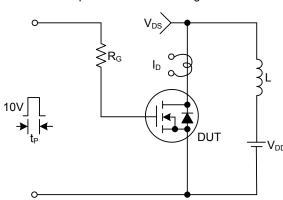
Resistive Switching Test Circuit



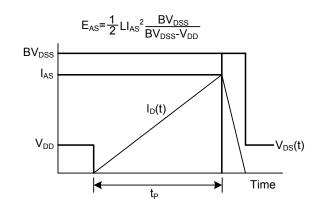
Resistive Switching Waveforms



Unclamped Inductive Switching Test Circuit

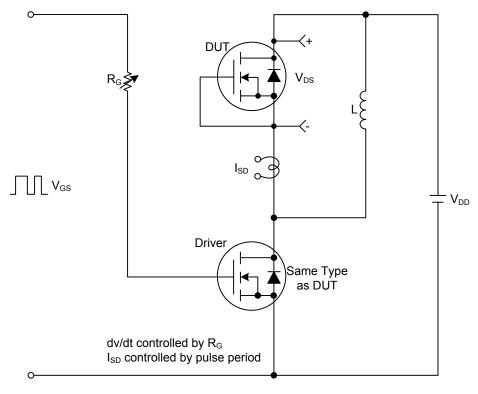


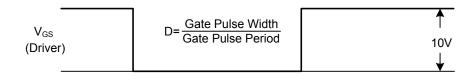
Unclamped Inductive Switching Waveforms

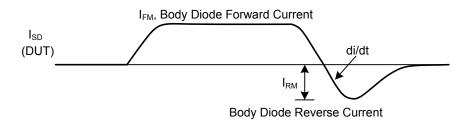


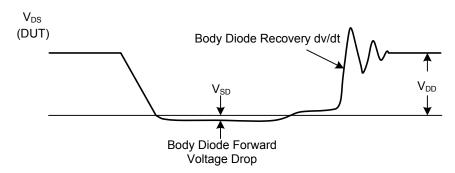
■ TEST CIRCUITS AND WAVEFORMS(Cont.)

Peak Diode Recovery dv/dt Test Circuit & Waveforms









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